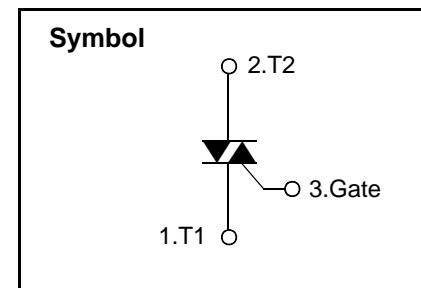
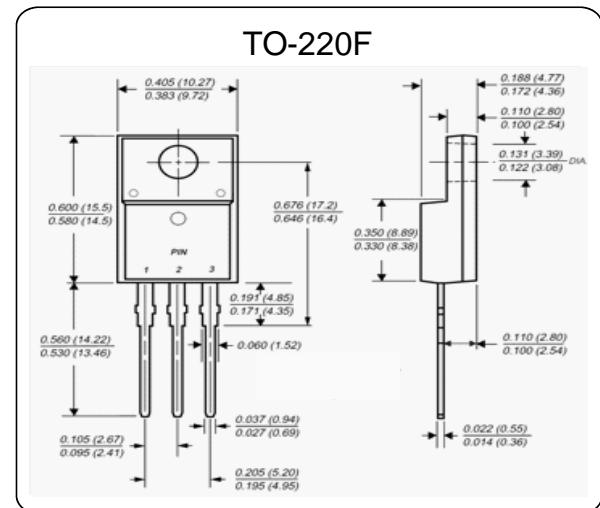


## **Bi-Directional Triode Thyristor**

Designed for high performance full-wave ac control applications where high noise immunity and high commutating di/dt are required.

### **Features**

- Blocking Voltage to 800 V
- On- State Current Rating of 12A RMS at 80 °C
- Uniform Gate Trigger Currents in Three Quadrants
- High Immunity to dV/dt- 1500V/us minimum at 125 °C
- Minimizes Snubber Networks for Protection
- Industry Standard TO- 220F Package
- High Commutating dI/dt- 4.0A/ms minimum at 125 °C
- Internally Isolated (2500VRMS)
- These are Pb- Free Devices



### **Absolute Maximum Ratings**

| Symbol                                 | Parameter  |         |                        | Value   | Unit             |
|--|--|---------|------------------------|---|------------------|
| I <sub>T(RMS)</sub>                    | RMS on-state current(full sine wave)   | TO-220F | T <sub>C</sub> =85 °C  | 12  | A                |
| I <sub>TSM</sub>                       | Non repetitive surge peak on-state current(full cycle, T <sub>j</sub> initial=25 °C) | F=50Hz  | t=20ms                 | 120   | A                |
|  |  | F=60Hz  | t=16.7ms               | 126   |                  |
| I <sup>2</sup> t                       | I <sup>2</sup> t Value for fusing  | tp=10ms |                        | 78  | A <sup>2</sup> s |
| DI/DT                                  | Critical rate of rise of on-state current<br>IG=2X <sub>IGT,tr≤100ns</sub>           |         | F=120Hz                | T <sub>j</sub> =125 °C                        | 50               |
| V <sub>DSTM/V</sub><br>R <sub>SM</sub> | Non repetitive surge peak off-state voltage  | tp=10ms | T <sub>j</sub> =25 °C  | V <sub>drm</sub> / v <sub>rmm</sub><br>+ 100V |                  |
| I <sub>GM</sub>                        | Peak gate current  | tp=20us | T <sub>j</sub> =125 °C | 4   | A                |
| P <sub>G(AV)</sub>                     | Average gate power dissipation   |         | T <sub>j</sub> =125 °C | 1   | W                |
| T <sub>stg</sub>                       | Storage junction temperature range   |         |                        | -40 to +150                                   | °C               |
| T <sub>j</sub>                         | Operating junction temperature range   |         |                        | -40 to +125                                   |                  |



# BT12F-800C

## Electrical Characteristics( $T_j=25^\circ\text{C}$ ,unless otherwise specified)

### Snubberless™ and Logic Level(3 quadrants)

| Symbol        | Test conditions  | Quadrant      | BT12F-800C |      | Unit |
|---------------|--|---------------|------------|------|------|
| $I_{GT}(1)$   | $V_D=12V \quad R_L=33\Omega$                                   | I - II - III  | MAX        | 35   | mA   |
| $V_{GT}$      |  | I - II - III  | MAX        | 1.3  | V    |
| $V_{GD}$      | $V_D=V_{DRM} \quad R_L=3.3K\Omega \quad T_j=125^\circ\text{C}$ | I - II - III  | MIN        | 0.2  | V    |
| $I_{H(2)}$    | $I_T=100\text{mA}$<br>$I_G=1.2I_{GT}$                          | I - III<br>II | MAX        | 50   | mA   |
| $I_L$         |  |               | MAX        | 70   | mA   |
|               |  |               |            | 80   |      |
| $Dv / Dt(2)$  | $VD=67\%V_{DRM}$ Gate open $T_j=125^\circ\text{C}$             |               | MIN        | 1000 | V/us |
| $(Dl/dt)c(2)$ | $(Dv/dt)c=0.1 \text{ V/us } T_j=125^\circ\text{C}$             | MIN           | -          | A/ms |      |
|               | $(Dv/dt)c=10\text{V/us } T_j=125^\circ\text{C}$                |               | -          |      |      |
|               | Without snubber $T_j=125^\circ\text{C}$                        |               | 12         |      |      |

### Standard (4Quadrants)

| Symbol        | Test conditions  | Quadrant     | BT12F-800C |     | Unit |
|---------------|--|--------------|------------|-----|------|
| $IGT(1)$      | $VD=12V \quad RL=33\Omega$                                   | I - II - III | MAX        | 35  | mA   |
| $V_{GT}$      |  | IV           |            | 50  |      |
| $V_{GD}$      | $VD=V_{DRM} \quad RL=3.3K\Omega \quad T_j=125^\circ\text{C}$ | ALL          | MAX        | 1.3 | V    |
| $I_{H(2)}$    | $IT=500\text{mA}$  |              | MAX        | 50  | mA   |
| $I_L$         | $IG=1.2IGT$  | I - III - IV | MAX        | 60  | mA   |
|               |  | II           |            | 120 |      |
| $(Dl/dt)(2)$  | $VD=67\%V_{DRM}$ Gate open $T_j=125^\circ\text{C}$           |              | MIN        | 400 | V/us |
| $(Dl/dt)c(2)$ | $(Dv/dt)c=7 \text{ A/ms } T_j=125^\circ\text{C}$             |              | MIN        | 10  | V/us |

### Static Characteristics

| Symbol                 | Test conditions                   | Value                   |     | Unit |                  |
|------------------------|-----------------------------------|-------------------------|-----|------|------------------|
| $VTM(2)$               | $ITM=11A \quad tp=380\mu\text{s}$ | $T_j=25^\circ\text{C}$  | MAX | 1.55 | V                |
| $V_{to}(2)$            | Threshold voltage                 | $T_j=125^\circ\text{C}$ | MAX | 0.85 | V                |
| $R_d(2)$               | Dynamic resistance                | $T_j=125^\circ\text{C}$ | MAX | 35   | $\text{m}\Omega$ |
| $I_{DRM}$<br>$I_{RRM}$ | $V_{DRM}=V_{RRM}$                 | $T_j=25^\circ\text{C}$  | MAX | 5    | $\mu\text{A}$    |
|                        |                                   | $T_j=125^\circ\text{C}$ |     | 2    | mA               |
| $V_{DRM}/V_{RRM}$      | Voltage                           | $T_j=25^\circ\text{C}$  | MIN | 800  | V                |

Note 1: minimum IGT is guaranteed at 5% of IGT max

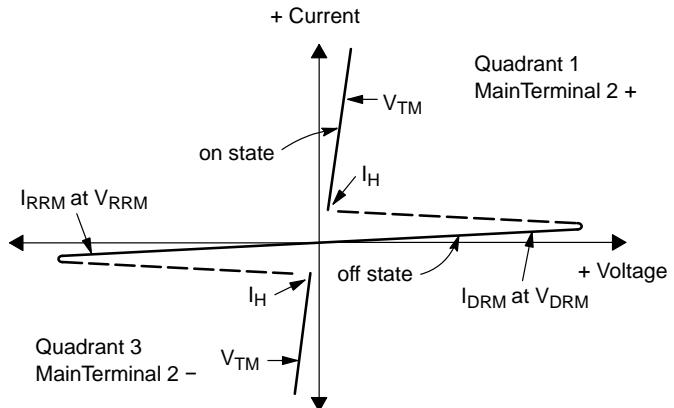
Note 2: for both polarities of A2 referenced to A1

### Thermal Resistances

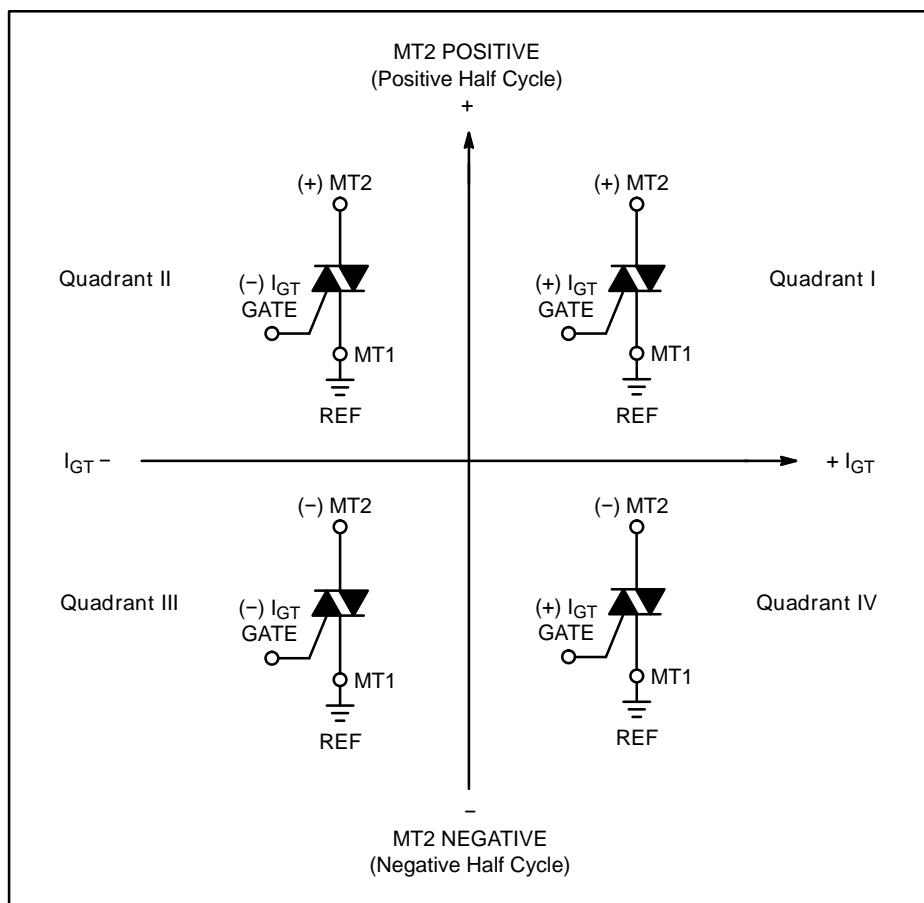
| Symbol        | Parameter            | Value   | Unit                   |
|---------------|----------------------|---------|------------------------|
| $R_{th(j-c)}$ | Junction to case(AC) | TO-220F | 2.3 $^\circ\text{C/W}$ |
| $R_{th(j-a)}$ | Junction to ambient  | TO-220F | 60 $^\circ\text{C/W}$  |

## Voltage Current Characteristic of Triacs (Bidirectional Device)

| Symbol    | Parameter                                 |
|-----------|---|
| $V_{DRM}$ | Peak Repetitive Forward Off State Voltage |
| $I_{DRM}$ | Peak Forward Blocking Current             |
| $V_{RRM}$ | Peak Repetitive Reverse Off State Voltage |
| $I_{RRM}$ | Peak Reverse Blocking Current             |
| $V_{TM}$  | Maximum On State Voltage                  |
| $I_H$     | Holding Current                           |

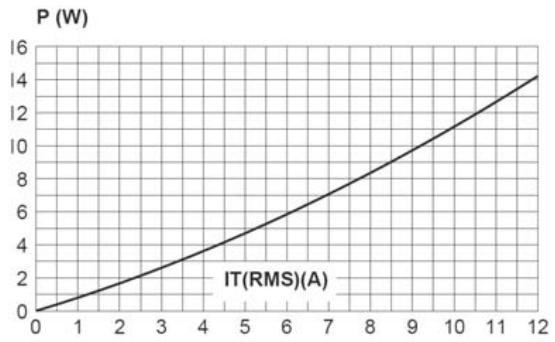


**Quadrant Definitions for a Triac**

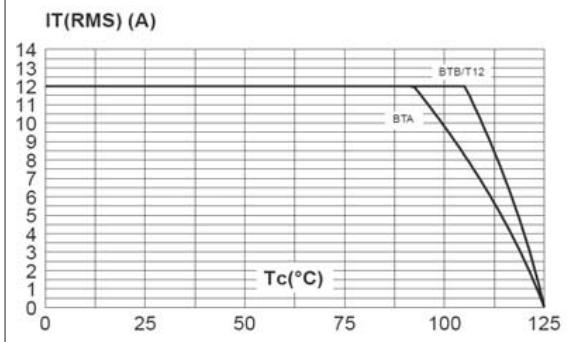


## Description

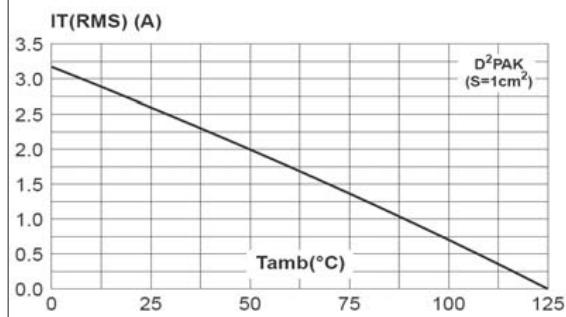
**Fig. 1:** Maximum power dissipation versus RMS on-state current (full cycle).



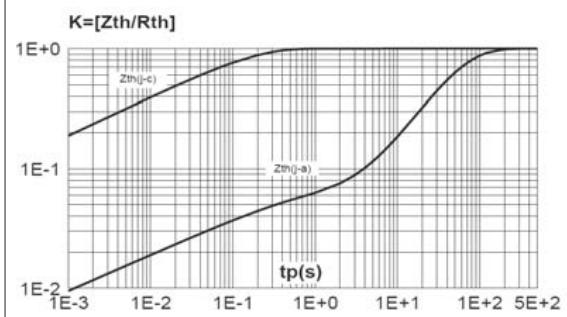
**Fig. 2-1:** RMS on-state current versus case temperature (full cycle).



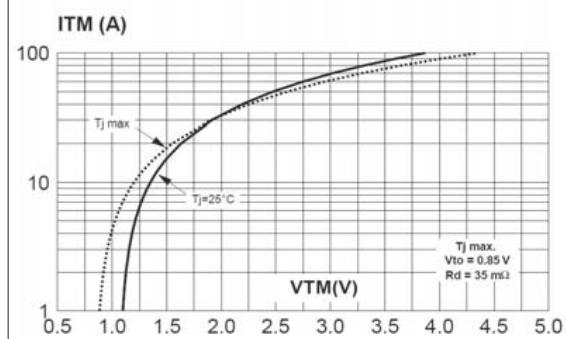
**Fig. 2-2:** RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness: 35µm), full cycle.



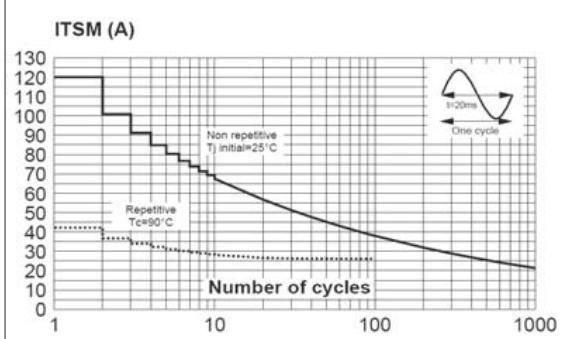
**Fig. 3:** Relative variation of thermal impedance versus pulse duration.



**Fig. 4:** On-state characteristics (maximum values).

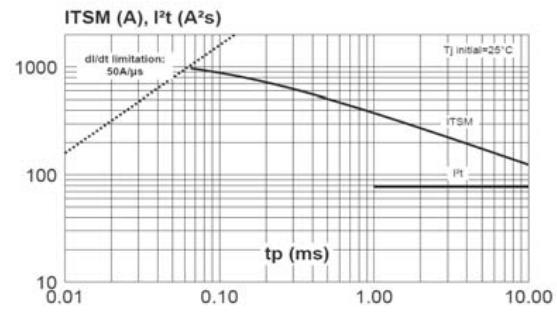


**Fig. 5:** Surge peak on-state current versus number of cycles.

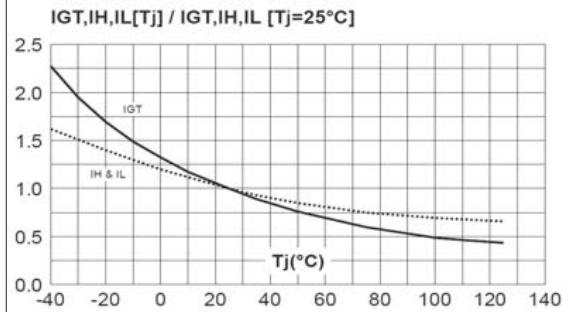


## Description

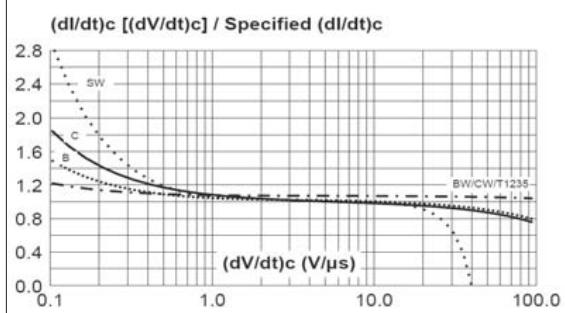
**Fig. 6:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$ , and corresponding value of  $I^2t$ .



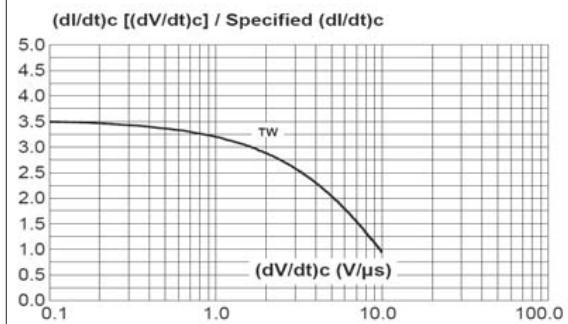
**Fig. 7:** Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).



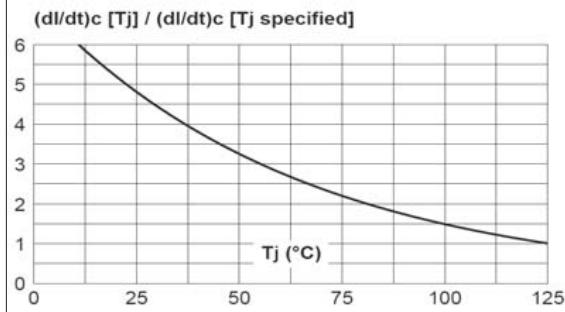
**Fig. 8-1:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)c$  (typical values) (BW/CW/T1235).



**Fig. 8-2:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)c$  (typical values) (TW).



**Fig. 9:** Relative variation of critical rate of decrease of main current versus junction temperature.



**Fig. 10:** D<sup>2</sup>PAK Thermal resistance junction to ambient versus copper surface under tab (printed circuit board FR4, copper thickness: 35  $\mu\text{m}$ ).

